

		APPLICATION FOR EXTENSION OF ESCC QUALIFICATION APPROVAL				Page 1 Appl. No. 230 G	
Component Title: Transistor, Microwave, Small Signal, Silicon, Bipolar Based on Types BFY180 thru BFY183, BFY193, BFY196 and BFY280		Executive Member: DLR		Date: 11/04/2016			
Components (including series and families) submitted for Extension of Qualification Approval:							1
ESCC COMPONENT NO.	VARIANTS	RANGE OF COMPONENTS	BASED ON	TEST VEHICLE / S	COMPONENT SIMILAR		
5611/006	01 to 08		BFY180, BFY280, BFY181, BFY182, BFY183, BFY193, BFY196		BFY450		
Component Manufacturer: Infineon Technologies AG		Location of Manufacturing Plant(s): Am Campeon 1-12 D-85579 Neubiberg Germany		Date of original qualification approval: Date: 01/06/1996 Certificate Ref No. 230			
ESCC Specifications used for Maintenance of qualification testing: Generic 5010 Issue: 02 : Detail(s) 5611/006 Issue: 03):		Deviations to LVT testing and Detail Specification used: No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> (supply details in Box 15) Deviation from current Specifications: No <input checked="" type="checkbox"/> Yes <input type="checkbox"/> (Supply details)		Qualification Extension Report reference and date: 1609LR10 Iss. 1, Mar 2016			
Summary of procurement or equivalent test results during current validity period in support of this application (those to ESCC listed first)							8
Project Name	Testing Level	LAT	Date code	Quantity Delivered			
PID changes since start of qualification None <input type="checkbox"/> Minor* <input checked="" type="checkbox"/> Major* <input type="checkbox"/> *Provide details in box:			Current PID Verified by: G. Joormann Name of Executive Representative Ref No: A63500 – T359 – P000 – * - 76K5 Issue: 3 Date: 26/04/2016 Rev Date: 01/04/2016				
PID adjusted to new Generic Spec 5010							
Current Manufacturing facilities surveyed by: G. Joormann (DGR) on 08/12/2015 (Name of Executive Representative) (Date)							11
Satisfactory: Yes <input checked="" type="checkbox"/> No <input type="checkbox"/> Explain							
Report Reference: IFX-AUD-2015							

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Failure Analysis, DPA, NCCS available: Yes ☐ No ☒ (Supply data)

Ref. No's and purposes:

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The undersigned hereby certifies on behalf of the ESCC Executive - that the above information is correct; -
that the appropriate documentation has been evaluated; - that full compliance to all ESCC requirements is evidence
(except as stated in box 15;) - that the reports and data are available at the ESCC Executive and therefore applies on behalf of
_____ as the responsible Executive Member for ESCC qualification status to be extended to the component(s) listed herein.

Date: 26.04.16

I. A. G. Joormann

(Signature of the Executive Coordinator)

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Continuation of Boxes above:



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Non compliance to ESCC requirements:

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No.:	Specification	Paragraph	Non compliance
1	5060	chart F4	no repetition of Endurance SG.

Additional tasks required to achieve full compliance for ESCC qualification or rationale for acceptability of noncompliance:

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Endurance Group at water lot level is agreed
and approved in The PID 57 (Qualification and
Similarity)

Executive Manager Disposition

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Application Approval: Yes ☒ No ☐

Action / Remarks:

inform customer via AP30126 by 15.03.01 that address is not possible

Date:

Signature, ESA Representative

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ANNEX 1: LIST OF TESTS DONE TO SUPPORT EXTENSION OF QUALIFICATION

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Tests conducted in compliance with:

- ESCC 5010 generic specification; Chart V (for ESCC/QPL parts);
- Or PID-TFD A63500-T359-P000_Detail_PID_BFY193ff (for ESCC/QML parts)

Tests vehicle identification/description:

BFY183(ES)	

Detail Specification reference: 5611 006 / 05

Chart V	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Environmental/Mechanical Subgroups	Thermal Shock Test	<input checked="" type="checkbox"/>	ESCC 5010 Para. 9.5.2	1512B	8	0	
	Shock Test	<input type="checkbox"/>	MIL-STD-750 Test Method 2016				n.a. acc. Detail Spec
	Vibration Test	<input type="checkbox"/>	MIL-STD-750 Test Method 2056				n.a. acc. Detail Spec
	Constant Acceleration	<input type="checkbox"/>	MIL-STD-750 Test Method 2006				n.a. acc. Detail Spec
	Seal Test	<input type="checkbox"/>	MIL-STD-750 Test Method 1071				n.a. acc. Detail Spec
	Moisture Resistance	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 1021	1512B	8	0	
	Seal Test	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 1071	1512B	8	0	
	Electrical Measurements at Room Temp.	<input checked="" type="checkbox"/>	Table 2 of the Detail Specification	1512B	8	0	
	External Visual Inspection	<input checked="" type="checkbox"/>	ESCC Basic Specification No. 20500	1512B	8	0	
Endurance Subgroup	Operating Life	<input type="checkbox"/>	MIL-STD-750 Test Method 1026				Former data from Wafer available *
	Electrical Measurements during Endur. Test	<input type="checkbox"/>	Table 6 of the Detail Specification				Former data from Wafer available *
	External Visual Inspection	<input type="checkbox"/>	ESCC Basic Specification No. 20500				Former data from Wafer available *

*LAT1 on assembly lot 1008.1, dc 1015A, on actual wafer.



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Chart V	Test	Tick when done	Conditions	Date Code Diffusion Lot	Tested Qty	No. of Rejects	Comments if not performed. Comments on Rejection
Electrical Subgroup - Electrical Measurements	Electrical Measurements at Room Temp.	<input checked="" type="checkbox"/>	Table 2 of the Detail Specification	1512B	4	0	
	Electrical Measurements at High & Low Temp's	<input checked="" type="checkbox"/>	Table 3 of the Detail Specification	1512B	4	0	
	External Visual Inspection	<input checked="" type="checkbox"/>	ESCC Basic Specification No. 20500	1512B	4	0	
	Special Testing	<input type="checkbox"/>	The Detail Specification				n.a. acc. Detail Spec
Electrical Subgroup - Assembly Capability Tests	Solderability Test	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 2026	1512B	4	0	
	Permanence of Marking	<input checked="" type="checkbox"/>	ESCC Basic Specification No. 24800	1512B	4	0	
	Terminal Strength	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 2036	1512B	4	0	
De-encapsulation Tests	Internal visual inspection	<input checked="" type="checkbox"/>	ESCC Basic Specification No. 20400	1512B	8	0	
	Bond Strength	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 2037	1512B	8	0	
	Die Shear	<input checked="" type="checkbox"/>	MIL-STD-750 Test Method 2017	1512B	8	0	

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NOTES ON THE COMPLETION OF THE APPLICATION FORM FOR ESCC QUALIFICATION EXTENSION APPROVAL**ENTRIES**

Form heading

shall indicate: - the title of the component as given in its detail specification or the name of the series, family; - the Executive Member; - the entering date; - the certificate number and its sequential suffix.

Box 1

shall provide details given in the table; in particular there shall be listed: - the variants or range of variants; - the range of components (the ESCC code is recommended to indicate the values or values range, the tolerance, the voltage, etc); the designation given in the detail specification as 'base on'; - under Test Vehicle enter either an ESCC code or the specific characteristic capable of identifying the component tested (e.g., voltage of coil for a relay); - under component similar enter a cross if relevant.

Box 2; 3 and 4

As per QPL entry; otherwise, an explanation of the changes must be supplied.

Box 5

Will show the ESCC Generic and Detail specifications, including issue number and revision letter, current at the time the tests reported were performed. If the specifications are different from those current on the date of the application, see Box 6.

Box 6

Will show the deviations from the Generic and Detail Specifications listed in Box 5, in particular deviations from testing. In case of deviations this must be listed in Box 15. In case the referenced specification in Box 5 have currently a different issue and/or revision indicate also whether the test data deviates or not from such current documents.

Box 7

Must reference the report(s) supplied in support of the application.

Box 8

Should provide the details of procurement to the full ESCC System, documentation of all of which should already have been delivered to the ESCC Executive under the terms of the relevant Generic Specification. An appropriate table has been drawn in this box.

Box 9

If the PID evolved after the Original Qualification or after the last Extension of Qualification, adequate details of such evolution shall be provided together with the reasons for the changes. Major changes shall be clearly marked.

Box 10

Identify the current PID issue status, date and actual date of verification. The date of verification of the current PID should be arranged as close as possible to the required date of extension.

Box 11

This box can be completed only after a physical visit to the plant to confirm that no unexplained changes occurred and that the practices, procedures, material, etc. used in manufacturing the components are as described in the PID. This survey shall be carried out in accordance with the requirements of ESCC Basic Specification No. 20200 and its findings shall be recorded.

Box 12

Provide details of, or reference to, any Destructive Physical Analysis (DPA) and Failure Analysis reports as well as any Nonconformance(s) (NCCS) occurred during the qualification validity period, stating if established corrective action have produced satisfactory results.

Box 13

Enter only the name of the Executive Member (i.e., CNES, DLR, ESTEC, etc.) and the signature of the responsible Executive Coordinator.

Box 14

To be used when there is a need to expand any of the boxes from 1 through 12. Identify box affected and reference the Box 14 in the relevant Box. Box 14 can be broken into 14a, 14b, etc. if several boxes have to be expanded.

Box 15

Fill in Table as requested.

Box 16

Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.

Box 17

All Executive Manager recommendations on the application itself, special conditions or restrictions, modifications of the QPL or QML entry, letters to the manufacturer, etc. shall be entered clearly in Box 19, signed by the representative for ESA, and dated.

Box 18

Fill in Table as requested.

Box 19

Confidential Details of PID changes including those of a confidential nature, shall be provided.

Box 20

State noncompliance with reference to specification(s) and paragraph(s). To simplify reference in Box 15 each nonconformance shall be sequentially numbered. If relevant state 'None'.

Box 21

Any additional action deemed necessary by the Executive Member to bring the submitted data to a standard likely to be accepted by the ESCC Executive should be listed herein or the reason(s) to accept the noncompliance.

Box 22

Additional Comments.